

Under the Paperwork Reduction Act of 1995, no persons are required to respond to a collection of information unless it contains a valid OMB control number.

Substitute for form 1449A/PTO INFORMATION DISCLOSURE STATEMENT BY APPLICANT (use as many sheets as necessary)				Complete if Known	
				Application Number	Not Yet Assigned
				Filing Date	July 3, 2002
				First Named Inventor	Kie Y. Ahn
				Art Unit	N/A 2814
				Examiner Name	Not Yet Assigned 10/184,233
Sheet	1	of	2	Attorney Docket Number	M4065.0216/P216-B

U. S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code ² (if known)			
AL	A**	4,188,415	02/1980	Takahashi et al.	
	B**	4,303,715	12/1981	Chang	
	C**	3,763,680	07/1972	Tanaka et al.	
	D**	5,153,986	10/1992	Brauer et al.	
	E**	3,934,335	01/1976	Nelson	
	F**	5,502,893	04/1996	Endoh et al.	
	G**	5,587,885	12/1996	Swamy	
	H**	3,602,635	08/1971	Romankiw	
	I**	5,557,142	09/1996	Gilmore et al.	
	J**	5,949,030	09/1999	Fasano et al.	
	K**	3,934,334	01/1976	Hanni	
	L**	4,582,564	04/1986	Shanefield et al.	
AL	M**	5,689,091	11/1997	Hamzehdoost et al.	

FOREIGN PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)			
AL	N**	JP 5-144221	06/1993	Sogo	
AL	O**	JP 3-171760	07/1991	Koizumi	

¹ Applicant's unique citation designation number (optional). ² See attached Kinds Codes of USPTO Patent Documents at www.uspto.gov or MPEP 901.04. ³ Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). ⁴ For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the application number of the patent document. ⁵ Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. ⁶ Applicant is to place a check mark here if English language Translation is attached.

Under the Paperwork Reduction Act of 1995, no persons are required to respond to a collection of information unless it contains a valid OMB control number.

Substitute for form 1449B/PTO INFORMATION DISCLOSURE STATEMENT BY APPLICANT (use as many sheets as necessary)		Complete if Known			
		Application Number	Not Yet Assigned		
		Filing Date	July 3, 2002		
		First Named Inventor	Kie Y. Ahn		
		Group Art Unit	2814		
		Examiner Name	Not Yet Assigned 10/784,233		
Sheet	2	of	2	Attorney Docket Number	M4065.0216/P216-A

OTHER PRIOR ART – NON PATENT LITERATURE DOCUMENTS			
Examiner Initials [*]	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²
AC	P**	Carsten Christensen et al., "WAFER THROUGH-HOLE INTERCONNECTIONS WITH HIGH VERTICAL WIRING DENSITIES," IEEE Transactions on Components ..., Part A, Vol. 19, No. 4, December 1996; pages 516-522.*	
	Q**	Michael Gribbons et al., "FINITE-DIFFERENCE TIME-DOMAIN ANALYSIS OF PULSE PROPAGATION IN MULTICHIP MODULE INTERCONNECTS," IEEE Transactions of Components Vol. 16, No. 5, 1993; pages 490-497.*	
	R**	R. Downing et al., "DECOUPLING CAPACITOR EFFECTS ON SWITCHING NOISE," IEEE Transactions of Components ..., Vol. 16, No. 5, 1993 pages 484-489.*	
	S**	T. Mimura et al., "SYSTEM MODULE: A NEW CHIP-ON-CHIP MODULE TECHNOLOGY," Semiconductor Research Center, Matsushita Electrical Industrial Co., Ltd., pages 21.5.1-21.5.4.*	
	T**	R. J. Jensen, "DESIGNING FOR RELIABILITY IN HARSH ENVIRONMENTS," MCM technology, Honeywell Solid State Electronics Center 1997.*	
AC	U**	Evan E. Davidson et al., "LONG LOSSY LINES (L ²) AND THEIR IMPACT UPON LARGE CHIP PERFORMANCE," IEEE Transactions ..., Part B, Vol. 20, No. 4, November 1997, pages 361-375.*	

Examiner Signature	<i>Alonzo Chambliss</i>	Date Considered	10/17/04
--------------------	-------------------------	-----------------	----------

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

¹Applicant's unique citation designation number (optional). ²Applicant is to place a check mark here if English language Translation is attached.